

Search Notes

Application/Control No.

10/594,282

Examiner

Sin J. Lee

Applicant(s)/Patent under
Reexamination

ISHII ET AL.

Art Unit

1795

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| east text search | 4/27/2008 | SJL |
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